PHP1N60E

# **GENERAL DESCRIPTION**

# N-channel enhancement mode field-effect power transistor in a plastic envelope featuring high avalanche energy capability, stable blocking voltage, fast switching and high thermal cycling performance with low thermal resistance. Intended for use in Switched Mode Power Supplies (SMPS), motor control circuits and general purpose switching applications.

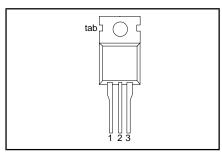
# **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>DS</sub> I <sub>D</sub> P <sub>tot</sub> R <sub>DS(ON)</sub>	Drain-source voltage Drain current (DC) Total power dissipation Drain-source on-state resistance	600 1.9 50 6	V A W Ω

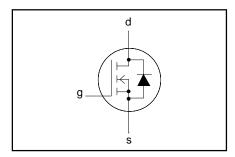
### **PINNING - TO220AB**

PIN	DESCRIPTION
1	gate
2	drain
3	source
tab	drain

# PIN CONFIGURATION



### **SYMBOL**



#### LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>DS</sub>	Drain-source voltage		•	600	V
$V_{DGR}$	Drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	600	V
$V_{DGR} \pm V_{GS}$	Gate-source voltage		-	30	V
I <sub>D</sub>	Drain current (DC)	$T_{mb} = 25 ^{\circ}C$	-	1.9	Α
	, ,	$T_{mb} = 100  ^{\circ}C$	-	1.2	Α
I <sub>DM</sub>	Drain current (pulse peak value)	$T_{mb}^{no} = 25 ^{\circ}C$	-	7.6	А
I <sub>DR</sub>	Source-drain diode current (DC)	$T_{mb} = 25 ^{\circ}C$	-	1.9	Α
I <sub>DRM</sub>	Source-drain diode current (pulse peak value)	$T_{mb} = 25 ^{\circ}C$	-	7.6	Α
P <sub>tot</sub>	Total power dissipation	$T_{mb} = 25 ^{\circ}C$	-	50	W
T <sub>stg</sub>	Storage temperature	THE	-55	150	°C
T <sub>i</sub>	Junction temperature		-	150	°C

# **AVALANCHE LIMITING VALUE**

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
W <sub>DSS</sub>	Drain-source non-repetitive unclamped inductive turn-off energy  Drain-source repetitive unclamped inductive turn-off energy	$\begin{split} I_D &= 1.9 \text{ A; } V_{DD} \leq 50 \text{ V; } V_{GS} = 10 \text{ V;} \\ R_{GS} &= 50 \Omega \\ & T_j = 25 ^{\circ}\text{C prior to surge} \\ T_j &= 100 ^{\circ}\text{C prior to surge} \\ I_D &= 1.9 \text{ A; } V_{DD} \leq 50 \text{ V; } V_{GS} = 10 \text{ V;} \\ R_{GS} &= 50 \Omega; T_j \leq 150 ^{\circ}\text{C} \end{split}$	- - -	120 20 3.6	mJ mJ

<sup>1.</sup> Pulse width and frequency limited by T<sub>i(max)</sub>

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# THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R <sub>th j-mb</sub>	Thermal resistance junction to		-	-	2.5	K/W
R <sub>th j-a</sub>	mounting base Thermal resistance junction to ambient		-	60	-	K/W

# STATIC CHARACTERISTICS

 $T_{mb}$  = 25 °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_{D} = 0.25 \text{ mA}$	600	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ ; $I_{D} = 0.25 \text{ mA}$	2.0	3.0	4.0	V
I <sub>DSS</sub>	Drain-source leakage current	$V_{DS} = 600 \text{ V}$ : $V_{GS} = 0 \text{ V}$ : $T_1 = 25 ^{\circ}\text{C}$	-	10	100	μΑ
500		$V_{DS} = 480 \text{ V}; V_{GS} = 0 \text{ V}; T_i = 125 ^{\circ}\text{C}$	-	0.1	1.0	mΑ
$I_{GSS}$	Gate-source leakage current	$V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nA
$R_{DS(ON)}$	Drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 0.9 \text{ A}$	-	5.3	6	Ω
$V_{SD}$	Source-drain diode forward voltage	$I_F = 1.9 \text{ A }; V_{GS} = 0 \text{ V}$	-	1.1	1.4	V

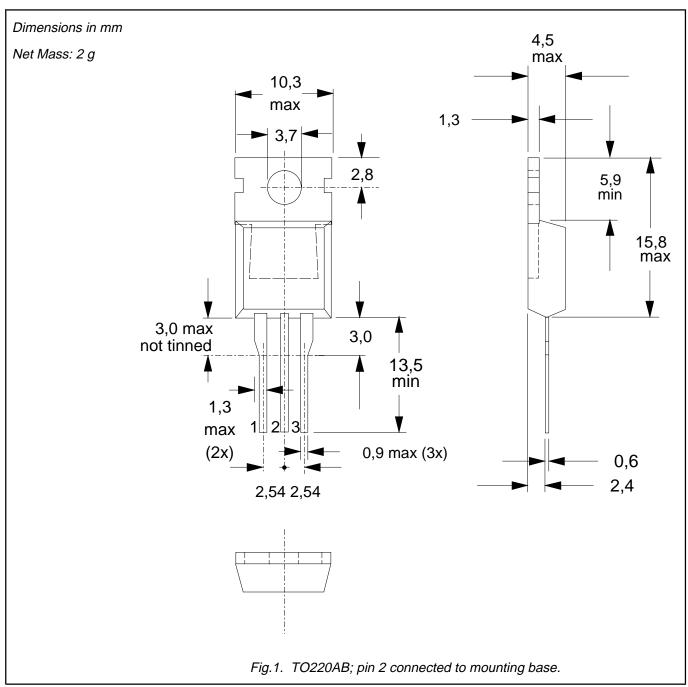
# **DYNAMIC CHARACTERISTICS**

 $T_{mb} = 25$  °C unless otherwise specified

PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Forward transconductance	$V_{DS} = 15 \text{ V}; I_{D} = 0.9 \text{ A}$	0.5	0.8	-	S
Input capacitance Output capacitance Feedback capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$		224 27 6	310 40 10	pF pF pF
Total gate charge Gate to source charge Gate to drain (Miller) charge	$V_{GS} = 10 \text{ V}; I_D = 1.9 \text{ A}; V_{DS} = 480 \text{ V}$	- - -	10 1 5	-	nC nC nC
Turn-on delay time Turn-on rise time Turn-off delay time Turn-off fall time	$\begin{aligned} V_{\text{DD}} &= 30 \text{ V; } I_{\text{D}} = 1.9 \text{ A;} \\ V_{\text{GS}} &= 10 \text{ V; } R_{\text{GS}} = 50 \Omega; \\ R_{\text{GEN}} &= 50 \Omega \end{aligned}$	- - -	10 30 30 20	15 45 40 30	ns ns ns ns
Source-drain diode reverse recovery time Source-drain diode reverse recovery charge	$I_F = 1.9 \text{ A}; -dI_F/dt = 100 \text{ A/}\mu\text{s};$ $V_{GS} = 0 \text{ V}; V_R = 100 \text{ V}$	-	350 3.5	-	ns μC
Internal drain inductance	Measured from contact screw on tab to centre of die	-	3.5	-	nΗ
Internal drain inductance Internal source inductance	Measured from drain lead 6 mm from package to centre of die Measured from source lead 6 mm	-	4.5 7.5	-	nH nH
	Forward transconductance Input capacitance Output capacitance Feedback capacitance Total gate charge Gate to source charge Gate to drain (Miller) charge Turn-on delay time Turn-onf delay time Turn-off delay time Turn-off fall time Source-drain diode reverse recovery time Source-drain diode reverse recovery charge Internal drain inductance Internal drain inductance	$ \begin{array}{llllllllllllllllllllllllllllllllllll$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

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# **MECHANICAL DATA**



- Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
   Refer to mounting instructions for TO220 envelopes.
   Epoxy meets UL94 V0 at 1/8".

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#### **DEFINITIONS**

Data sheet status				
Objective specification	This data sheet contains target or goal specifications for product development.			
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.			
Product specification	This data sheet contains final product specifications.			
Product specification	This data sheet contains final product specifications.			

#### Limiting values

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

#### **Application information**

Where application information is given, it is advisory and does not form part of the specification.

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